

This listing of claims will replace all prior versions, and listings, of claims in the application:

**Listing of Claims:**

1. (currently amended): A magnetic head including a read head element, comprising:

a pinned magnetic layer;

a free magnetic layer having a central portion thereof having a free magnetization therewithin;

a magnetic bias layer, including a central portion thereof that is disposed across said central portion of said free magnetic layer;

said central portion of said bias layer being comprised of a material having an approximately zero magnetic moment;

a pair of electrical leads being disposed above said bias layer and on opposite sides of said central portion of said bias layer;

a barrier layer being disposed across said central portion of said bias layer, wherein said barrier layer is ~~disposed only upon said central portions of said bias layer and upon said electrical leads~~ not disposed between said electrical leads except in said location of across said central portion of said bias layer.

2. (original): A magnetic head as described in claim 1 wherein said central portion of said bias layer is comprised of an oxidized material, and said barrier layer is comprised of a material that is a barrier to oxygen diffusion from said central portion of said bias layer.

1 3. (original): A magnetic head as described in claim 2, further including a thin spacer layer  
2 that is disposed upon said free magnetic layer, wherein said bias layer is disposed upon said thin  
3 spacer layer and said barrier layer is deposited upon said bias layer.

1 4. (original): A magnetic head as described in claim 3 wherein said barrier layer is  
2 comprised of a material that has low electrical conductivity.

1 5. (original): A magnetic head as described in claim 4 wherein said barrier layer is  
2 comprised of Ru or Rh.

1 6. (original): A magnetic head as described in claim 5 wherein said barrier layer is  
2 comprised of Ru having a thickness of from approximately 5 Å to approximately 40 Å.

1 7. (original): A magnetic head as described in claim 6 wherein said barrier layer has a  
2 thickness of approximately 20 Å.

1 8. (original): A magnetic head as described in claim 3 wherein said thin spacer layer is  
2 comprised of a material that is a barrier to oxygen diffusion.

1 9. (original): A magnetic head as described in claim 8 wherein said thin spacer layer is  
2 comprised of Ru.

1 10. (currently amended): A hard disk drive including a magnetic head including a read head  
2 element, comprising:

3 a pinned magnetic layer;

4 a free magnetic layer having a central portion thereof having a free magnetization  
5 therewithin;

6 a magnetic bias layer, including a central portion thereof that is disposed across said  
7 central portion of said free magnetic layer;

8 said central portion of said bias layer being comprised of a material having an  
9 approximately zero magnetic moment;

10 a pair of electrical leads being disposed above said bias layer and on opposite sides of  
11 said central portion of said bias layer;

12 a barrier layer being disposed across said central portion of said bias layer, wherein said  
13 barrier layer is ~~disposed only upon said central portions of said bias layer and upon said electrical~~  
14 ~~leads~~ not disposed between said electrical leads except in said location of across said central  
15 portion of said bias layer.

1 11. (original): A magnetic head as described in claim 10 wherein said central portion of said  
2 bias layer is comprised of an oxidized material, and said barrier layer is comprised of a material  
3 that is a barrier to oxygen diffusion from said central portion of said bias layer.

1 12. (original): A magnetic head as described in claim 11, further including a thin spacer  
2 layer that is disposed upon said free magnetic layer, wherein said bias layer is disposed upon said  
3 thin spacer layer and said barrier layer is deposited upon said bias layer.

1 13. (original): A magnetic head as described in claim 12 wherein said barrier layer is  
2 comprised of a material that has low electrical conductivity.

1 14. (original): A magnetic head as described in claim 13 wherein said barrier layer is  
2 comprised of Ru or Rh.

1 15. (original): A magnetic head as described in claim 14 wherein said barrier layer is  
2 comprised of Ru having a thickness of from approximately 5 Å to approximately 40 Å.

1 16. (original): A magnetic head as described in claim 15 wherein said barrier layer has a  
2 thickness of approximately 20 Å.

1 17. (original): A magnetic head as described in claim 12 wherein said thin spacer layer is  
2 comprised of a material that is a barrier to oxygen diffusion.

1 18. (original): A magnetic head as described in claim 17 wherein said thin spacer layer is  
2 comprised of Ru.

1 19. (previously presented): A method for fabricating a magnetic head, comprising:  
2 fabricating a free magnetic layer;  
3 fabricating a magnetic bias layer across said free magnetic layer;  
4 fabricating electrical leads above portions of said bias layer;  
5 oxidizing a central portion of said bias layer;  
6 depositing an oxygen diffusion barrier layer upon said oxidized central portion of said  
7 bias layer and upon said electrical leads; and

8 removing portions of said barrier layer that are deposited at locations other than upon said  
9 electrical leads and upon said central portions of said bias layer.

1 20 (original): A method for fabricating a magnetic head as described in claim 19 wherein  
2 said barrier layer is comprised of Ru or Rh.

1 21. (original): A method for fabricating a magnetic head as described in claim 20 wherein  
2 said barrier layer is comprised of Ru and has a thickness of from approximately 5 Å to  
3 approximately 40 Å.

1 22. (original): A method for fabricating a magnetic head as described in claim 21 wherein  
2 said barrier layer is formed with a thickness of approximately 20 Å.